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# Onsemi

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## HUF76633P3-F085

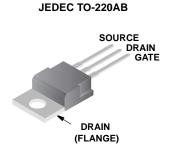


#### Data Sheet

April 2012

#### 38A, 100V, 0.036 Ohm, N-Channel, Logic Level UltraFET® Power MOSFET

#### Packaging



#### Symbol





#### Features

- Ultra Low On-Resistance
  - $r_{DS(ON)} = 0.035\Omega$ ,  $V_{GS} = 10V$
  - $r_{DS(ON)} = 0.036\Omega, V_{GS} = 5V$
- · Simulation Models
  - Temperature Compensated PSPICE® and SABER™ **Electrical Models**
  - Spice and SABER Thermal Impedance Models
- Peak Current vs Pulse Width Curve
- · UIS Rating Curve
- Switching Time vs R<sub>GS</sub> Curves
- Qualified to AEC Q101
- RoHS Compliant

#### **Ordering Information**

PART NUMBER	PACKAGE	BRAND
HUF76633P3-F085	TO-220AB	76633P

#### Absolute Maximum Ratings $T_C = 25^{\circ}C$ , Unless Otherwise Specified

	Ratings	Units
Drain to Source Voltage (Note 1) V <sub>DSS</sub>	100	V
Drain to Gate Voltage ( $R_{GS} = 20k\Omega$ ) (Note 1) $V_{DGR}$	100	V
Gate to Source VoltageV <sub>GS</sub>	±16	V
Drain Current		
Continuous (T <sub>C</sub> = 25 <sup>o</sup> C, V <sub>GS</sub> = 5V)I <sub>D</sub>	38	А
Continuous (T <sub>C</sub> = $25^{\circ}$ C, V <sub>GS</sub> = 10V) (Figure 2) I <sub>D</sub>	39	А
Continuous (T <sub>C</sub> = $100^{\circ}$ C, V <sub>GS</sub> = 5V) I <sub>D</sub>	27	А
Continuous (T <sub>C</sub> = 100 <sup>o</sup> C, V <sub>GS</sub> = 4.5V) (Figure 2)I <sub>D</sub>	27	A
Pulsed Drain Current	Figure 4	
Pulsed Avalanche Rating UIS	Figures 6, 17, 18	
Power Dissipation	145	W
Derate Above 25°C	0.97	W/ <sup>o</sup> C
Operating and Storage Temperature T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s	300	°C
Package Body for 10s, See Techbrief TB334	260	°C
NOTES:		

#### 1. $T_J = 25^{\circ}C$ to $150^{\circ}C$ .

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

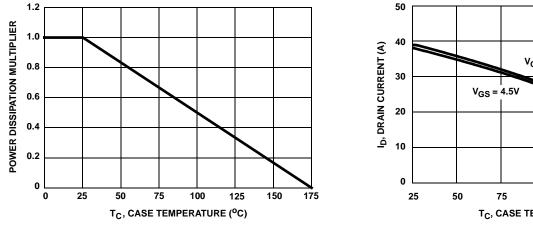
All ON semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN	TYP	MAX	UNITS
OFF STATE SPECIFICATIONS						1	
Drain to Source Breakdown Voltage	BV <sub>DSS</sub>	$I_{D} = 250 \mu A, V_{GS} = 0 V$	' (Figure 12)	100	-	-	V
		$I_D = 250\mu A$ , $V_{GS} = 0V$ , $T_C = -40^{\circ}C$ (Figure 12)		90	-	-	V
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 95V, V <sub>GS</sub> = 0V		-	-	1	μA
		$V_{DS} = 90V, V_{GS} = 0V$	, T <sub>C</sub> = 150 <sup>o</sup> C	-	-	250	μA
Gate to Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = \pm 16V$		-	-	±100	nA
ON STATE SPECIFICATIONS	I			L	1		1
Gate to Source Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu$	A (Figure 11)	1	-	3	V
Drain to Source On Resistance	rDS(ON)	I <sub>D</sub> = 39A, V <sub>GS</sub> = 10V	(Figures 9, 10)	-	0.029	0.035	Ω
		$I_{D} = 27A, V_{GS} = 5V (F)$	Figure 9)	-	0.030	0.036	Ω
		I <sub>D</sub> = 27A, V <sub>GS</sub> = 4.5V	(Figure 9)	-	0.031	0.037	Ω
THERMAL SPECIFICATIONS					u		<u>.</u>
Thermal Resistance Junction to Case	$R_{\theta JC}$	TO-220 and TO-263		-	-	1.03	oC/M
Thermal Resistance Junction to Ambient	R <sub>θJA</sub>			-	-	62	°C/W
SWITCHING SPECIFICATIONS ( $V_{GS}$ =	= 4.5V)			1	1	1	1
Turn-On Time	ton	$V_{DD} = 50V, I_D = 27A$		-	-	185	ns
Turn-On Delay Time	<sup>t</sup> d(ON)	V <sub>GS</sub> = 4.5V, R <sub>GS</sub> = 4.7Ω (Figures 15, 21, 22)		-	12	-	ns
Rise Time	t <sub>r</sub>			-	110	-	ns
Turn-Off Delay Time	<sup>t</sup> d(OFF)			-	43	-	ns
Fall Time	t <sub>f</sub>			-	58	-	ns
Turn-Off Time	tOFF			-	-	150	ns
SWITCHING SPECIFICATIONS ( $V_{GS}$ =	= 10V)				1		
Turn-On Time	<sup>t</sup> ON	$V_{DD} = 50V, I_{D} = 39A$ $V_{GS} = 10V,$ $R_{GS} = 5.1\Omega$ (Figures 16, 21, 22)		-	-	95	ns
Turn-On Delay Time	t <sub>d(ON)</sub>			-	7.5	-	ns
Rise Time	t <sub>r</sub>			-	55	-	ns
Turn-Off Delay Time	<sup>t</sup> d(OFF)			-	63	-	ns
Fall Time	t <sub>f</sub>			-	83	-	ns
Turn-Off Time	tOFF			-	-	220	ns
GATE CHARGE SPECIFICATIONS							
Total Gate Charge	Q <sub>g(TOT)</sub>	$V_{GS} = 0V$ to 10V	$V_{DD} = 50V,$ $I_{D} = 27A,$ $I_{g(REF)} = 1.0mA$ (Figures 14, 19, 20)	-	56	67	nC
Gate Charge at 5V	Q <sub>g(5)</sub>	$V_{GS} = 0V$ to 5V		-	30	37	nC
Threshold Gate Charge	Q <sub>g(TH)</sub>	$V_{GS} = 0V$ to 1V		-	2	2.4	nC
Gate to Source Gate Charge	Q <sub>gs</sub>			-	6	-	nC
Gate to Drain "Miller" Charge	Q <sub>gd</sub>			-	15	-	nC
CAPACITANCE SPECIFICATIONS					u		
Input Capacitance	C <sub>ISS</sub>	$V_{DS} = 25V, V_{GS} = 0V$	3	-	1820	-	pF
Output Capacitance	C <sub>OSS</sub>	☐ f = 1MHz (Figure 13)		-	415	-	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			-	115	-	pF

#### Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage	V <sub>SD</sub>	I <sub>SD</sub> = 27A	-	-	1.25	V
		I <sub>SD</sub> = 13A	-	-	1.0	V
Reverse Recovery Time	t <sub>rr</sub>	$I_{SD} = 27A, dI_{SD}/dt = 100A/\mu s$	-	-	113	ns
Reverse Recovered Charge	Q <sub>RR</sub>	I <sub>SD</sub> = 27A, dI <sub>SD</sub> /dt = 100A/μs	-	-	425	nC

#### Typical Performance Curves





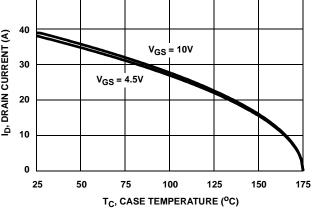
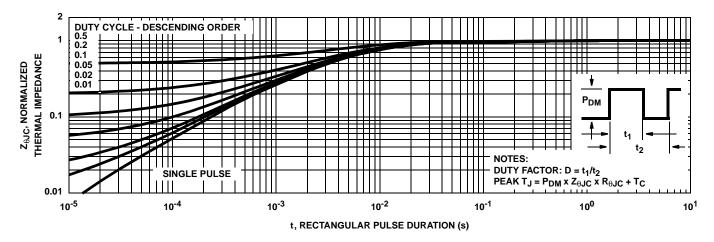
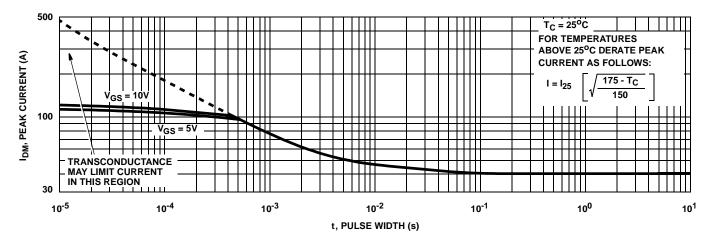


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs **CASE TEMPERATURE** 









#### Typical Performance Curves (Continued)

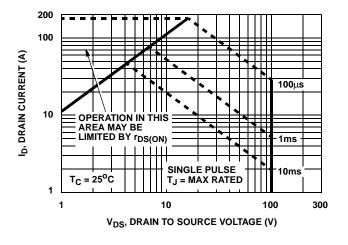


FIGURE 5. FORWARD BIAS SAFE OPERATING AREA

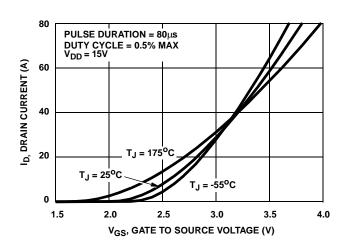


FIGURE 7. TRANSFER CHARACTERISTICS

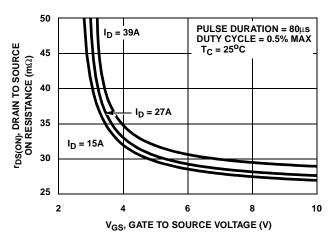
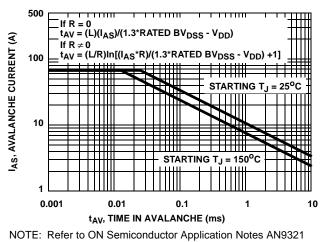


FIGURE 9. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT



and AN9322.

FIGURE 6. UNCLAMPED INDUCTIVE SWITCHING CAPABILITY

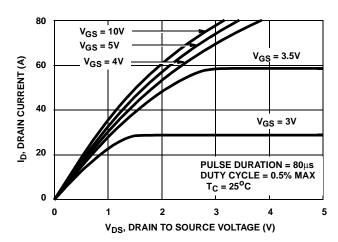


FIGURE 8. SATURATION CHARACTERISTICS

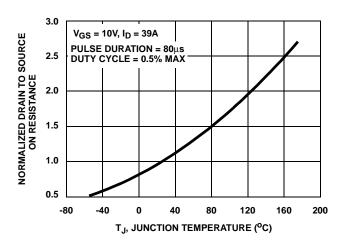
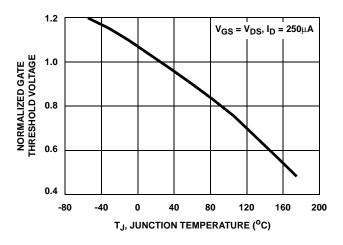


FIGURE 10. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

#### Typical Performance Curves (Continued)





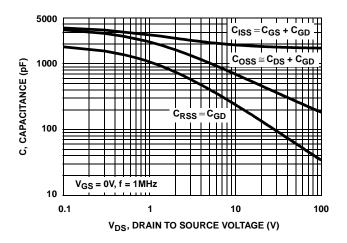


FIGURE 13. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

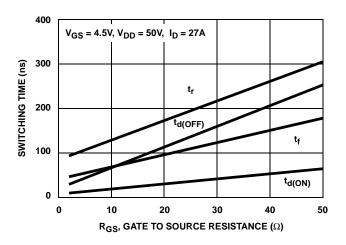


FIGURE 15. SWITCHING TIME vs GATE RESISTANCE

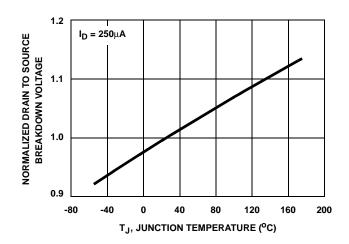
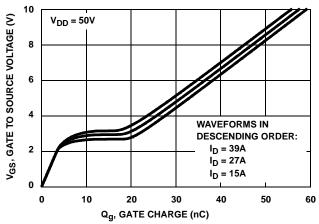
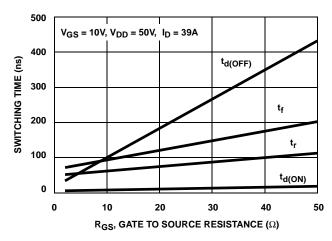


FIGURE 12. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE



NOTE: Refer to ON Semiconductor Application Notes AN7254 and AN7260.

FIGURE 14. GATE CHARGE WAVEFORMS FOR CONSTANT GATE CURRENT





### Test Circuits and Waveforms

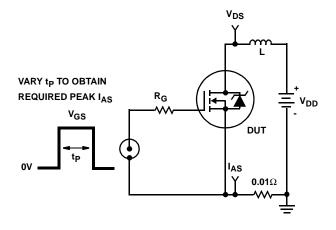


FIGURE 17. UNCLAMPED ENERGY TEST CIRCUIT

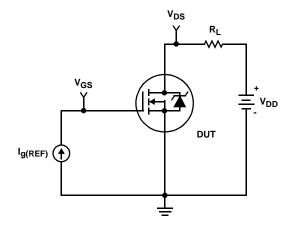


FIGURE 19. GATE CHARGE TEST CIRCUIT

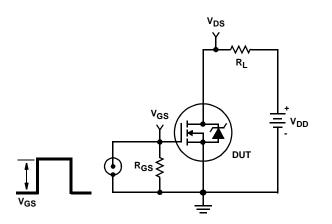


FIGURE 21. SWITCHING TIME TEST CIRCUIT

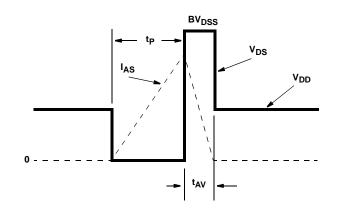


FIGURE 18. UNCLAMPED ENERGY WAVEFORMS

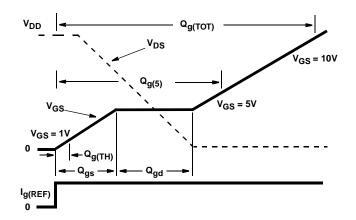


FIGURE 20. GATE CHARGE WAVEFORMS

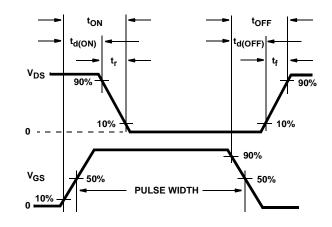
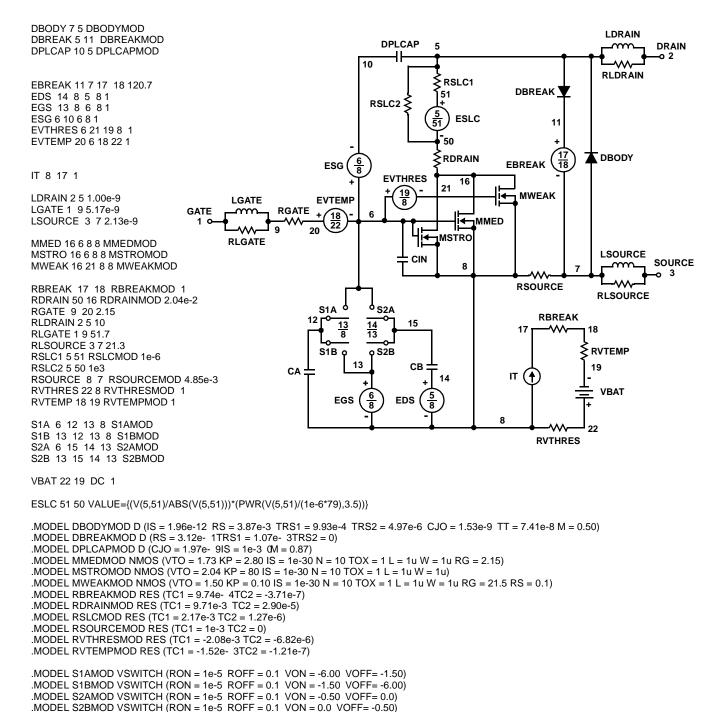


FIGURE 22. SWITCHING TIME WAVEFORM

#### **PSPICE Electrical Model**

.SUBCKT HUF76633 2 1 3 ; rev 10 September1999

CA 12 8 3.50e-9 CB 15 14 3.50e-9 CIN 6 8 1.70e-9



.ENDS

NOTE: For further discussion of the PSPICE model, consult **A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.

#### SABER Electrical Model

REV 10 September 1999 template huf76633 n2,n1,n3 electrical n2,n1,n3 var i iscl d..model dbodymod = (is = 1.96e-12, cjo = 1.53e-9, tt = 7.41e-8, m = 0.50) d..model dbreakmod = () d..model dplcapmod = (cjo = 1.97e-9, is = 1e-30, m = 0.87) m..model mmedmod = (type=\_n, vto = 1.73, kp = 2.8, is = 1e-30, tox = 1) m..model mstrongmod = (type=\_n, vto = 2.04, kp = 80, is = 1e-30, tox = 1) m..model mweakmod = (type=\_n, vto = 1.50, kp = 0.1, is = 1e-30, tox = 1) LDRAIN sw\_vcsp..model s1amod = (ron = 1e-5, roff = 0.1, von = -6.00, voff = -1.50) DPLCAP 5 DRAIN sw\_vcsp..model s1bmod = (ron =1e-5, roff = 0.1, von = -1.50, voff = -6.00) o 2 sw\_vcsp...model s2amod = (ron = 1e-5, roff = 0.1, von = -0.50, voff = 0.0) 10 RLDRAIN sw\_vcsp..model s2bmod = (ron = 1e-5, roff = 0.1, von = 0.0, voff = -0.50) RSLC1 RDBREAK 51 c.ca n12 n8 = 3.50e-9 RSLC2 ≥ 72 c.cb n15 n14 = 3.50e-9 RDBODY ISCL c.cin n6 n8 = 1.70e-9 DBREAK 50 d.dbody n7 n71 = model=dbodymod 71 d.dbreak n72 n11 = model=dbreakmod 6 8 ESG 11 d.dplcap n10 n5 = model=dplcapmod EVTHRES 16 21 19 8 MWEAK i.it n8 n17 = 1 i∙ LGATE EVTEMP DBODY RGATE GATE 6 18 22 EBREAK I.Idrain n2 n5 = 1e-9 MMED i∙ 1 C 9  $\sim$ 20 l.lgate n1 n9 = 5.17e-9 MSTR RLGATE l.lsource n3 n7 = 2.13e-9 LSOURCE CIN SOURCE 8 m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u 3 m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u RSOURCE m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u RLSOURCE S1A os2A res.rbreak n17 n18 = 1, tc1 = 9.74e-4, tc2 = -3.71e-7 RBREAK <u>13</u> 8 <u>14</u> 13 15 res.rdbody n71 n5 = 3.87e-3, tc1 = 9.93e-4, tc2 = 4.97e-6 17 18 res.rdbreak n72 n5 = 3.12e-1. tc1 = 1.07e-3. tc2 = 0 RVTEMP res.rdrain n50 n16 = 20.40e-3, tc1 = 9.71e-3, tc2 = 2.90e-5 o S2B S1B res.rgate n9 n20 = 2.15 13 СВ 19 CA res.rldrain n2 n5 = 10 IT (♠ 14 res.rlgate n1 n9 = 51.7 VBAT <u>6</u> 8 res.rlsource n3 n7 = 21.3 5 EGS EDS res.rslc1 n5 n51 = 1e-6, tc1 = 2.17e-3, tc2 = 1.27e-6 8 res.rslc2 n5 n50 = 1e3 22 res.rsource n8 n7 = 4.85e-3, tc1 = 1.00e-3, tc2 = 0 RVTHRES res.rvtemp n18 n19 = 1. tc1 = -1.52e-3. tc2 = 1.21e-7 res.rvthres n22 n8 = 1, tc1 = -2.08e-3, tc2 = -6.82e-6 spe.ebreak n11 n7 n17 n18 = 120.7 spe.eds n14 n8 n5 n8 = 1 spe.egs n13 n8 n6 n8 = 1 spe.esg n6 n10 n6 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1 spe.evthres n6 n21 n19 n8 = 1 sw\_vcsp.s1a n6 n12 n13 n8 = model=s1amod sw\_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw\_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw\_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc=1 equations { i (n51->n50) +=iscl

#### SPICE Thermal Model

#### REV 9 September1999

#### HUF76633T

CTHERM1 th 6 2.90e-3 CTHERM2 6 5 1.25e-2 CTHERM3 5 4 1.00e-2 CTHERM4 4 3 6.50e-3 CTHERM5 3 2 2.75e-2 CTHERM6 2 tl 12.55

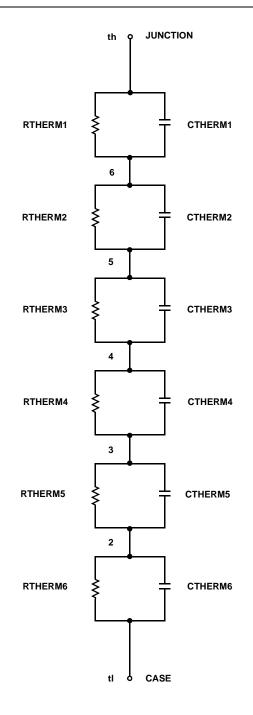
RTHERM1 th 6 7.04e-3 RTHERM2 6 5 1.75e-2 RTHERM3 5 4 4.94e-2 RTHERM4 4 3 2.77e-1 RTHERM5 3 2 4.18e-1 RTHERM6 2 tl 5.54e-2

#### SABER Thermal Model

SABER thermal model HUF76633T

template thermal\_model th tl thermal\_c th, tl { ctherm.ctherm1 th 6 = 2.90e-3 ctherm.ctherm2 6 5 = 1.25e-2 ctherm.ctherm3 5 4 = 1.00e-2 ctherm.ctherm4 4 3 = 6.50e-3 ctherm.ctherm5 3 2 = 2.75e-2 ctherm.ctherm6 2 tl = 12.55 rtherm.rtherm1 th 6 = 7.04e-3 rtherm.rtherm2 6 5 = 1.75e-2

rtherm.rtherm3 5 4 =  $4.94e^{-2}$ rtherm.rtherm4 4 3 =  $2.77e^{-1}$ rtherm.rtherm5 3 2 =  $4.18e^{-1}$ rtherm.rtherm6 2 tl =  $5.54e^{-2}$ 



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